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... using a new system combining quasi-static (QST) analysis with in-situ CDM and HBM ESD **simulation** capabilities. ... [5] **Integral Solutions International**, San Jose ...

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1999 EOS

... 2A.7 A **Simulation** Analysis of Quarter-Micron CMOS LSI Input Circuit ... Heads as a function of Temperature, C.Moore, **Integral Solutions International**; A. Wallash ...

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Electrostatic Discharge Association

... of GMR Heads subjected to CDM and HBM ESD Events C. Moore, **Integral Solutions International**. ... QST) analysis with in-situ CDM and HBM ESD **simulation** capabilities. ...

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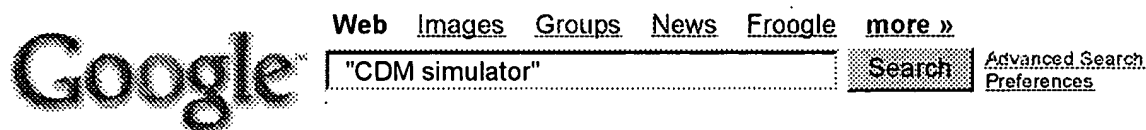


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notice about ESD and clean room package chairs. ESD package chairs discharge the electro-static charge of the human body by a safe ...

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ATM R&D Project Synopses

... movement Planning Ref: EEC. 10/2003, Y. RDI, R&D Infrastructure. **CDM Simulator**

Development Ref: EEC. 12/2003, Y. Responsible Organisation ...

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ESD Test Equipment - July 1995

... The **CDM simulator** typically charges a device lying upside down on a 1/32"-thick insulating material by applying a voltage through a high-resistance probe and ...

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代理產品. 代理廠商(美國/韓國). 代理產品. INDUSTRIAL EQUIPMENT. **CDM SIMULATOR**. IRDA TEST SYSTEM. OPEN/SHORT TESTER. ESD TESTER. ESD & LATCH-UP TESTER. ...

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>>ESD Measurement Products>>ESD/CDM Simulator, Manufacturer, TOKYO ELECTRONICS TRADING CO. LTD. 日本 <http://www.tet.co.jp>. Model NO. ...

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Charged Device

... THE **CDM SIMULATOR**: At a standard charged device modelling simulator the device under test is placed on dielectric, charged by a power supply and discharged ...

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1 Coherent addition of intermodulation distortion in spectrum analyzer
Stepanek, P.; Kurtz, D.; Gorin, J.;

Microwave Symposium Digest, 2003 IEEE MTT-S International , Volume: 2 , 8 June 2003

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2 A reconfigurable fault-tolerant signal processor
Shively, R.R.; Gorin, A.L.;

Acoustics, Speech, and Signal Processing, 1989. ICASSP-89., 1989 International Conference on , 23-26 May 1989

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Horikawa, S.; Daito, I.; Doshita, N.; Gorin, A.; Hasegawa, T.; Horikawa, N.; Iwata, T.; Kondo, K.; Kuroda, K.; Manuilov, I.; Matsuda, T.; Miyachi, Y.; Riazantsev, Takabayashi, N.; Toeda, T.; Torimitsu, S.;

Nuclear Science, IEEE Transactions on , Volume: 49 , Issue: 3 , June 2002

Pages:950 - 956

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A.; Hasegawa, T.; Matsuda, T.; Kuroda, K.-I.;
Nuclear Science Symposium Conference Record, 2001 IEEE , Volume: 1 , 4-1
Nov. 2001
Pages:559 - 563 vol.1

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5 Analysis of current distribution in the zone of high speed sliding contact of the pulsed electromechanical converters

Chemerys, V.T.; Gorin, V.V.;
Pulsed Power Plasma Science, 2001. IEEE Conference Record - Abstracts , 17
June 2001
Pages:530

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6 Adaptive language acquisition using incremental learning

Farrell, K.; Mammone, R.J.; Gorin, A.L.;
Acoustics, Speech, and Signal Processing, 1993. ICASSP-93., 1993 IEEE
International Conference on , Volume: 1 , 27-30 April 1993
Pages:501 - 504 vol.1

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